

Analyzing Measurements Over Time to Understand Circuit Performance

Using the TBS1000B TrendPlot™ Function

Application Note

Introduction

Oscilloscopes with automated measurements have made it easier for engineers to quickly find and fix problems or characterize performance of their products. But sometimes that's not enough. Although oscilloscopes are excellent at providing snapshots of waveform information that reflect one moment in time, sometimes engineers need to see how waveforms behave over time. This application note discusses how the TrendPlot[™] function can be used to efficiently measure circuit behavior over time, as conditions such as temperature or input voltages change.

Background

Oscilloscopes display waveforms in a graphical format that plots voltage measurements against time. Many scopes can also display the results of measurements derived from the waveform data that appears on the screen, or in the acquisition record. The measurements provide only a snapshot of the signal's behavior. If the scope is set to the "free run" mode, the measurement results will generally change as new waveform information becomes available. But in order to see any trends in measurements over time, one needs to sit in front of the scope and manually record the measurement results by hand, a tedious, time consuming process. What's more, it's easy for faults to be missed, such as instances when a measurement jumps outside an expected range and then reads normally again shortly thereafter.

The TrendPlot function is specifically designed to address these types of monitoring challenges. It directs the oscilloscope to continuously monitor signals, and plots the measurement data on the display screen. Using TrendPlot, engineers can simultaneously monitor any one or two automated measurements. It can then plot those measurements on the oscilloscope display, or save the information directly into a connected USB memory device. Faults can be easily found when measurement results appear outside of the expected range. The data can then be analyzed to see what trends have occurred over time or as conditions changed.





Figure 1. Line voltage measurements (cycle RMS and peak-to-peak voltage) made with P5200A High Voltage Differential Probe on Channel 1.

With the TrendPlot measurement vs. time feature added to the toolset, your oscilloscope becomes an even more powerful tool to use for design validation.

Using TrendPlot for design validation:

- Monitor power supply stability over time
- Verify circuit design specifications
- Capture intermittent events, and troubleshoot random shut-downs
- Plot critical parameters per test point during climate testing temperature cycles
- Perform temperature controlled crystal oscillator circuit tests

Application Examples

Let's say that you need to debug a power controller ramp-up failure, and you plan to use 4-corner testing (testing at the four combinations given by max-min values of temperature and input voltage). Under certain conditions, the power controller output ramp-up time exceeds the system requirements, causing a system power-on failure. You want to know the temperature and input voltage conditions that cause the failure to occur.

To determine this, you can use the TrendPlot function to monitor the signal rise time during the ramp-up period.



Figure 2. TrendPlot traces show a line voltage dropout by recording cycle RMS and peak-to-peak voltage over a few minutes. The red trace indicates that the cycle RMS measurement is unable to detect cycles during the dropout, and therefore temporarily unable to make the measurement.

Begin by attaching a TPP0101 passive probe to the output of the DUT's power module (the DUT is in ae temperature chamber) and connect the probe's BNC to CH1 of the TBS1102B oscilloscope. On the oscilloscope follow the steps below to enable the TrendPlot function:

- Power on the oscilloscope, press "default setup" and "Autoset", and then select " " in the autoset menu. Adjust the settings for vertical scale and position, horizontal scale and position, and trigger level and position so that the rising portion of the signal fills the screen.
- 2. Press Measure and then press the "Ch1" bezel button; select the "rise time" measurement (see Figure 1).
- Set the temperature and voltage of the DUT's power module to one of the 4 voltage / temperature combinations: {max_V, max_T}, {min_V, max_T}, {min_V, min_T}, {max_V, min_T} to see if the power controller output ramp-up time exceeds the system requirements. Suppose that the output ramp-up time satisfies the system requirements under the following conditions: {max_V, max_T}, {min_V, min_T}, {max_V, min_T}, but exceeds it under the {min_V, max_T} condition. This means the rise time gets longer when the voltage is low or when the temperature is high.
- 4. Now you start to set up the TrendPlot function. Press the "Function" menu and the "TrendPlot" bezel button to enter the TrendPlot sub-menu.

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Figure 3. The rising portion of the signal fills the screen.





- 5. Press the "Source1" bezel button and select CH1 as the signal source. Then press the "Type 1" bezel button and select "Rise Time".
- 6. Set the initial voltage/ temperature conditions of the power controller to {max_V, max_T}.
- Press the "Trend Plot Run/Off" bezel button to switch to the "Run" state. The plot scans from the left to right. The "Min", "Max", and "Avg" values of the rise time for the duration of the test can be read below the upper plot (see Figure 2).
- 8. To find the voltage at which the rise time goes out of specification, decrease the voltage of the power controller slowly from max_V to min_V, while the temperature is held steady, until the rise time reaches the maximum value the system allows. Press the "Trend Plot Run/Off" bezel button to stop the Trendplot. The final voltage is the minimum that results in a valid rise time. (see Figure 3).



Figure 5. Rise time trend while decreasing the voltage.



Figure 6. Rise time trend while increasing temperature.

- To determine the temperature at which the rise time goes out of specification, set the voltage and temperature conditions of the power controller to {min_V, min_T}.
- 10. Press the "Trend Plot Run/Off" bezel button again to re-start the Trendplot. Increase the temperature of the power controller slowly from min_T to max_T, while the voltage is held steady, until the rise time reaches the maximum value the system allows. The final temperature is the maximum that results in an acceptable rise time (see Figure 4).

Conclusion

TrendPlot is a powerful debugging tool that can monitor circuit behavior over time to observe slowly changing trends, and capture intermittent faults. Using a Tektronix TBS1000B Series oscilloscope with TrendPlot[™] functionality, an engineer can monitor two measurements simultaneously for minutes, hours or even days.

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